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| Notice of References Cited | Application/Control No. 10/580,289 | | Applicant(s)/Patent Under Reexamination TAM ET AL. | |
| | Examiner Kelvin L. Randall, JR. | | Art Unit 4174 | Page 1 of 2 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------------|----------------|
| * | A | US-1,913,722 A | 06-1933 | PERRIN JAY C | 225/16 |
| * | B | US-3,503,481 A | 03-1970 | BRENNER STANLEY S | 194/240 |
| * | C | US-3,586,207 A | 06-1971 | Brenner, Stanley | 221/259 |
| * | D | US-3,685,691 A | 08-1972 | Charest et al. | 221/225 |
| * | E | US-3,754,370 A | 08-1973 | Hanson, Neil L. | 53/459 |
| * | F | US-4,032,038 A | 06-1977 | Hendricks et al. | 221/71 |
| * | G | US-4,802,606 A | 02-1989 | Daniels, Duane D. | 221/39 |
| * | H | US-4,912,906 A | 04-1990 | Toner, Frank T. | 53/463 |
| * | I | US-5,167,301 A | 12-1992 | Cappi et al. | 186/66 |
| * | J | US-5,249,787 A | 10-1993 | Ifkovits, Edward M. | 271/6 |
| * | K | US-5,492,398 A | 02-1996 | Schafer, Christopher E. | 312/34.7 |
| * | L | US-5,641,039 A | 06-1997 | Dumont, Charles | 186/61 |
| * | M | US-5,833,230 A | 11-1998 | Nakagawa et al. | 271/121 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
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| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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|-----------------------------------|---------------------------------------|--|--|-------------|
| Notice of References Cited | Application/Control No. 10/580,289 | | Applicant(s)/Patent Under Reexamination TAM ET AL. | |
| | Examiner Kelvin L. Randall, JR. | | Art Unit 4174 | Page 2 of 2 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| * | A | US-5,890,344 A | 04-1999 | Smith et al. | 53/447 |
| * | B | US-6,006,495 A | 12-1999 | Varichon et al. | 53/384.1 |
| * | C | US-2002/0117578 A1 | 08-2002 | Denen et al. | 242/563 |
| * | D | US-2004/0082454 A1 | 04-2004 | White et al. | 493/189 |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | DE 4034863 A1 | 05-1992 | Germany | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
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NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
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| | V | |
| | W | |
| | X | |

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